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Client: ruixiang Certificate No: 24J02Z000006

CALIBRATION CERTIFICATE

Object DAE4 - SN: 1286

Calibration Procedure(s)

FF-211-002-01

Calibration Procedure for the Data Acquisition Electronics

(DAEx)

Calibration date: February 22, 2024

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3) ℃ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Process Calibrator 753	1971018	12-Jun-23 (CTTL, No.J23X05436)	Jun-24

Name Function

Calibrated by: Yu Zongying SAR Test Engineer

Reviewed by: Lin Jun SAR Test Engineer

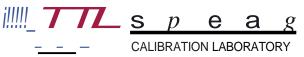
Approved by: Qi Dianyuan SAR Project Leader

Signature

Issued: February 26, 2024

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Certificate No: 24J02Z000006 Page 1 of 3





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Glossary:

DAE data acquisition electronics

Connector angle information used in DASY system to align probe sensor X

to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other performance test results.

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DC Voltage Measurement

AID - Converter Resolution nominal

Calibration Factors X		у	Z	
High Range	404.068 ± 0.15% (k=2)	403.984 ± 0.15% (k=2)	403.859 ±0.15% (k=2)	
Low Range	3.96155 ± 0.7% (k;:::2)	3.99309 ± 0.7% (k=2)	3.97421 ±0.7% (k=2)	

Connector Angle

Connector Angle to be used in DASY system

 $328.5^{\circ}\pm1^{\circ}$

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INNOWAVE



Certificate No: J23Z60222

CALIBRATION CERTIFICATE

Object

EX3DV4 - SN: 7624

Calibration Procedure(s)

FF-Z11-004-02

Calibration Procedures for Dosimetric E-field Probes

Calibration date:

September 06, 2023

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID# Ca	al Date(Calibrated by, Certificate No.) Scheduled (Calibration
Power Meter NRP2	101919	12-Jun-23(CTTL, No.J23X05435)	Jun-24
Power sensor NRP-Z91	101547	12-Jun-23(CTTL, No.J23X05435)	Jun-24
Power sensor NRP-Z91	101548	12-Jun-23(CTTL, No.J23X05435)	Jun-24
Reference 10dBAttenuator	18N50W-10dB	19-Jan-23(CTTL, No.J23X00212)	Jan-25
Reference 20dBAttenuator	18N50W-20dB	19-Jan-23(CTTL, No.J23X00211)	Jan-25
Reference Probe EX3DV4	SN 3846	31-May-23(SPEAG, No.EX-3846_May23)	May-24
DAE4	SN 549	24-Jan-23(SPEAG, No.DAE4-549_Jan23)	Jan-24
DAE4	SN 1744	30-Aug-22(SPEAG, No.DAE4-1744_Aug22)	Aug-23
Secondary Standards	ID#	0.15.4/0.00	Scheduled Calibration
SignalGenerator MG3700A	6201052605	12-Jun-23(CTTL, No.J23X05434)	Jun-24
Network Analyzer E5071C	MY46110673	10-Jan-23(CTTL, No.J23X00104)	Jan-24
Reference 10dBAttenuator	BT0520	11-May-23(CTTL, No.J23X04061)	May-25
Reference 20dBAttenuator	BT0267	11-May-23(CTTL, No.J23X04062)	May-25
OCP DAK-3.5	SN 1040	18-Jan-23(SPEAG, No.OCP-DAK3.5-1040_Jan2	
Nam	Δ .	Function	-, -, -, -, -, -, -, -, -, -, -, -, -, -

Name Function Signature

Calibrated by: Yu Zongying SAR Test Engineer

Reviewed by: Lin Hao SAR Test Engineer

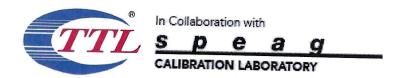
Approved by: Qi Dianyuan SAR Project Leader

Issued: September 12, 2023

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Glossary:

TSL tissue simulating liquid NORMx,y,z sensitivity in free space

ConvF sensitivity in TSL / NORMx,y,z

DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters

Polarization Φ rotation around probe axis

Polarization θ θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i

 θ =0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Measurement procedure for the assessment of Specific Absorption Rate (SAR) from hand-held and body-mounted devices used next to the ear (frequency range of 300 MHz to 6 GHz)", July 2016
- c) IEĆ 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization θ =0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx, y, z are only intermediate values, i.e., the uncertainties of NORMx, y, z does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This
 linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the
 frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z;VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).





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DASY/EASY - Parameters of Probe: EX3DV4 - SN:7624

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m)²) ^A	0.57	0.59	0.58	±10.0%
DCP(mV) ^B	112.6	113.4	119.4	210.070

Modulation Calibration Parameters

UID	Communication		Α	В	С	D	VR	Unc ^E
	System Name		dB	dBõV		dB	mV	(<i>k</i> =2)
0	CM	X	0.0	0.0	1.0	0.00	200.3	±4.7%
		Υ	0.0	0.0	1.0		212.4	
		Z	0.0	0.0	1.0		202.8	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 4).

E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.





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DASY/EASY - Parameters of Probe: EX3DV4 - SN:7624

Calibration Parameter Determined in Head Tissue Simulating Media

					3		
Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G	Unct. (<i>k</i> =2)
41.9	0.89	10.58	10.58	10.58	0.20		±12.7%
41.5	0.90	10.19					±12.7%
40.1	1.37	8.66					±12.7%
40.0	1.40						±12.7%
39.8	1.49						±12.7%
39.5	1.67	8.13					±12.7%
39.2	1.80	7.85					±12.7%
39.0	1.96	7.66					±12.7%
37.9	2.91	7.20					±13.9%
37.7	3.12	7.00					±13.9%
37.5	3.32						±13.9%
37.2	3.53						±13.9%
37.1	3.63				100100		$\pm 13.9\%$
36.9	3.84	6.61					±13.9%
36.7	4.04	6.47	6.47				±13.9%
36.4	4.25	6.37					±13.9%
36.3	4.40	6.08					±13.9%
35.9	4.71	5.55					±13.9%
35.5	5.07						±13.9%
35.4	5.22						±13.9%
	Permittivity F 41.9 41.5 40.1 40.0 39.8 39.5 39.2 39.0 37.9 37.7 37.5 37.2 37.1 36.9 36.4 36.3 35.9 35.5	Permittivity F (S/m) F 41.9 0.89 41.5 0.90 40.1 1.37 40.0 1.40 39.8 1.49 39.5 1.67 39.2 1.80 39.0 1.96 37.9 2.91 37.7 3.12 37.5 3.32 37.1 3.63 36.9 3.84 36.7 4.04 36.4 4.25 36.3 4.40 35.9 4.71 35.5 5.07	Permittivity F (S/m) F ConvF X 41.9 0.89 10.58 41.5 0.90 10.19 40.1 1.37 8.66 40.0 1.40 8.35 39.8 1.49 8.27 39.5 1.67 8.13 39.2 1.80 7.85 39.0 1.96 7.66 37.9 2.91 7.20 37.5 3.32 6.85 37.2 3.53 6.78 37.1 3.63 6.68 36.9 3.84 6.61 36.7 4.04 6.47 36.3 4.40 6.08 35.9 4.71 5.55 35.5 5.07 4.96	Permittivity F (S/m) F ConvF X ConvF Y 41.9 0.89 10.58 10.58 41.5 0.90 10.19 10.19 40.1 1.37 8.66 8.66 40.0 1.40 8.35 8.35 39.8 1.49 8.27 8.27 39.5 1.67 8.13 8.13 39.2 1.80 7.85 7.85 39.0 1.96 7.66 7.66 37.9 2.91 7.20 7.20 37.7 3.12 7.00 7.00 37.5 3.32 6.85 6.85 37.1 3.63 6.68 6.68 36.9 3.84 6.61 6.61 36.7 4.04 6.47 6.47 36.3 4.40 6.08 6.08 35.9 4.71 5.55 5.55 35.5 5.07 4.96 4.96	Permittivity F (S/m) F ConvF X ConvF Y ConvF Z 41.9 0.89 10.58 10.58 10.58 41.5 0.90 10.19 10.19 10.19 40.1 1.37 8.66 8.66 8.66 40.0 1.40 8.35 8.35 8.35 39.8 1.49 8.27 8.27 8.27 39.5 1.67 8.13 8.13 8.13 39.2 1.80 7.85 7.85 7.85 39.0 1.96 7.66 7.66 7.66 37.9 2.91 7.20 7.20 7.20 37.7 3.12 7.00 7.00 7.00 37.5 3.32 6.85 6.85 6.85 37.1 3.63 6.68 6.68 6.68 36.9 3.84 6.61 6.61 6.61 36.7 4.04 6.47 6.47 6.47 36.3 4.40 6.08	Relative Permittivity F Conductivity (S/m) F ConvF X ConvF Y ConvF Z Alpha ^G 41.9 0.89 10.58 10.58 10.58 0.20 41.5 0.90 10.19 10.19 10.19 0.19 40.1 1.37 8.66 8.66 8.66 0.21 40.0 1.40 8.35 8.35 8.35 0.33 39.8 1.49 8.27 8.27 8.27 0.23 39.5 1.67 8.13 8.13 8.13 0.58 39.2 1.80 7.85 7.85 7.85 0.63 39.0 1.96 7.66 7.66 7.66 0.65 37.9 2.91 7.20 7.20 7.20 0.34 37.7 3.12 7.00 7.00 7.00 0.36 37.5 3.32 6.85 6.85 6.85 0.30 37.1 3.63 6.68 6.68 6.68 0.30 36.9 </td <td>Relative Permittivity F Conductivity (S/m) F ConvF X ConvF Y ConvF Z Alpha (mm) Depth (mm) 41.9 0.89 10.58 10.58 10.58 0.20 1.06 41.5 0.90 10.19 10.19 10.19 0.19 1.20 40.1 1.37 8.66 8.66 8.66 0.21 1.13 40.0 1.40 8.35 8.35 8.35 0.33 0.91 39.8 1.49 8.27 8.27 8.27 0.23 1.08 39.5 1.67 8.13 8.13 8.13 0.58 0.67 39.2 1.80 7.85 7.85 7.85 0.63 0.66 39.0 1.96 7.66 7.66 7.66 0.65 0.65 37.9 2.91 7.20 7.20 7.20 0.34 1.00 37.5 3.32 6.85 6.85 6.85 0.30 1.50 37.2 3.53 6.78</td>	Relative Permittivity F Conductivity (S/m) F ConvF X ConvF Y ConvF Z Alpha (mm) Depth (mm) 41.9 0.89 10.58 10.58 10.58 0.20 1.06 41.5 0.90 10.19 10.19 10.19 0.19 1.20 40.1 1.37 8.66 8.66 8.66 0.21 1.13 40.0 1.40 8.35 8.35 8.35 0.33 0.91 39.8 1.49 8.27 8.27 8.27 0.23 1.08 39.5 1.67 8.13 8.13 8.13 0.58 0.67 39.2 1.80 7.85 7.85 7.85 0.63 0.66 39.0 1.96 7.66 7.66 7.66 0.65 0.65 37.9 2.91 7.20 7.20 7.20 0.34 1.00 37.5 3.32 6.85 6.85 6.85 0.30 1.50 37.2 3.53 6.78

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

F At frequency up to 6 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to $\pm 10\%$ if liquid compensation formula is applied to measured SAR values. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

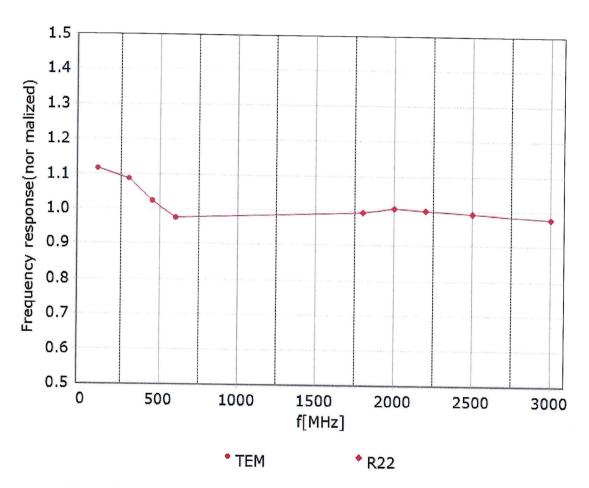
^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.



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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 7.4\%$ (k=2)